

## ESD Simulator for Electronics Parts

#### Reproduce ESD phenomena variably

 Simulator to reproduce electrostatic discharges (ESD) which are caused by a charged human body or machine designed with capacitor type and discharge the ESD to electronic devices for evaluating the resistibility against ESD.

In case the discharger is a human body, the test is called as Human Body Model (HBM) and in case it is a metallic object, the test is called as Machine Model (MM). This simulator is available to perform the both tests.

#### ■Target or potential customers

- Communication equipments (Mobile phone, mobile network devices, etc.)
- Materials (Plastic resin, film board, etc.)
- Electronic devices (Semiconductor, LED, crystal oscillator, SAW filter etc.)
- Others (Electric or electronic equipments demanded for EMC tests)

#### Test standards

- MIL-STD-883
- EIAJ ED-4701 etc.
- Individual industrial standards
- Private standards by manufacturers



<sup>\* &</sup>quot;Private standards by manufacturers" shall be discussed separately

#### **ESD Simulator for Electronics Parts**

# ESS-6002 /6008

#### Feature

- Optimal for testing sensitive devices because of the output voltage from 10V (1V step)(ESS-6002).
- Enables to evaluate the robustness against the breakdown voltage with the output voltage up to 8kV (10V step).(ESS-6008)
- The direct discharge to the IC clip is available with the free board equipment
- Constant qualitative discharge is available with the semi-automatic operation (in Semi-Automatic Precision Type).
- Available both for Human Body Model (HBM) test and Machine Model (MM) test
- Enable to discharge standards waveforms in between terminals
- Caracteristics variation of DUT can be verified with measurement terminal (The measurement equipment is necessary besides)
- Enable to set the faster rise-up (with an optional card)



Semi-automatic precision type probe stand

Human Body Model (HBM)	Machine Model (MM)
AEC-Q100-002-Rev.D Jul.2003	AEC-Q100-003-REV -E Jul.2003
ESDA ANSI/EOS/ESD-STM5.1-2001	ESDA ANSI/ ESD STM5.2-1999
IEC 61340-3-1Ed.1.0 2002	IEC 61340-3-2 Ed.1.0-2002
IEC 60749-26 Ed.1.0 2003	IEC 60749-27 Ed.1.0 2003
JEDEC JESD22- A114E Jan.2007	JEDEC JESD22- A115A Oct.1997
JEITA EIAJ ED-4701/300 Aug.2001 Test Method304	JEITA EIAJ ED-4701/300 Aug.2001 Reference Test Method
MIL-STD-883F 3015.7 Mar.1989	

Specification	
Parameter	Specification
Output voltage	ESS-6002 10~2000V±10% (1V step)
	ESS-6008 100~8000V±10% (10V step)
Porality	Positive and negative
Repetition period	0.3~99s±10%
	0.1s step to 10s, 1s step over 10s
EXT TRIG IN	±15V Max BNC coaxial connector
	Operation in TTL fall-down (LOW over than 100µs or short between terminals)
STAGE CONTROL	Control with pptional semi-automatic precision type probe stand (MODEL 18-00076A) Dsub connector
INTERLOCK	Stop test when open on the termial board or between terminals
Power supply	AC100~240V±10% 50Hz / 60Hz
Power consumption	25VA
Operating temperature range	15~35°C
Storage temperature range	-10~50°C
Operating humidity range	25~75%RH (without dew)
Storage temperature range	0~85%RH (without dew)
Dimension	(W) 340 X (H) 199 X (D) 300mm (Projecxtion excluded)
Mass	Approx. 6kg



Machine Model (MM) Probe 01	-00055A
Parameter	Specification
Operating temperature / humidity range	15~35°C / 25~75%RH (without dew)
Dimension / Mass	(W) 50 X (H) 242 X (D) 54mm / Approx. 760g
CR	C:200pF±10% B:0Q

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Outnut	waveform	ı at ehort

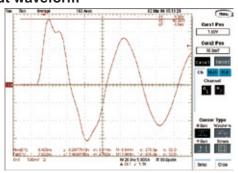
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Voltage	1st peak current	2nd peak current	Cycle	Ringing
	lp 1	lp 2		Irs
100V	1.75A±10%			
200V	Min: 3.5A -10%			
	Max.: 3.8Z	Min: 67% of Ip 1	Min: 66ns	≦30% of Ip 1
400V	7.5A±10%	Max: 90% of lp 2	Max:90nx	
800V	14A±10%			

## Output waveform at 500Ω(±1%) load Voltage Peak current Current at

voitage	Peak current	Current at 100ns	Current at 200ns
	lpr	1100nx	1200ns
100V	_	_	_
200V	-	_	_
400V	Min : 0.85A	0.29A±10%	Min : 35% of 100ns
	Max: 1.1745A		Max: 45% of 100ns
800V	_	_	

<sup>\*</sup> Output voltage depends on capbilities of the simulator (ESS-6002 / 6008)

#### Output waveform



#### MM PROBE

#### Human Body Model (HBM) Probe 01-00054A

Parameter	Specification
Operating temperature / humidity range	15~35°C / 25~75%RH (without dew)
Dimension / Mass	(W) 50 X (H) 242 X (D) 54mm / Approx. 760g.
CR	C : 100pF±10% R : 1.5kΩ±1%

#### Output waveform at short

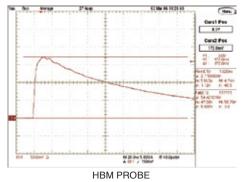
Voltage	Peak current lps	Rise time Trs	Fall down time Tds	Ringing Irs
250V 500V	0.17A±10% 0.33A ±10%			
1000V	0.67A±10%	Min : 2ns	Min : 1.3ns	
2000V	1.33A±10%	Max:10ns	Max : 1.7nx	<15% of lps
4000V	2.67A±10%			
8000V	5.33A±10%			

#### Output waveform at 500 $\Omega$ (±1%) load

Voltage	Peak current	lpr/lps	Rse time	Fall down time	Ringing
	lpr		Trs	Tds	Irs
250V	-	-	_	-	_
500V	min:60% of lps	≧63%	5~25ns	200ns±40ns	≦15%
	max:0.25A-25%				
1000V	min:60% of lps	≧63%	5~25ns	200ns±40ns	≦15%
	max:0.5A-25%				
2000V	min:60% of lps	≧63%	5~25ns	200ns±40ns	≦15%
	max:1.0A-25%				
4000V	min:60% of lps	≧63%	5~25ns	200ns±40ns	≦15%
	max:2.0A-25%				
8000V	_	_	_	_	_
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 $<sup>^{\</sup>star}$  Output voltage depends on capbilties of the simulator (ESS-6002 / 6008)

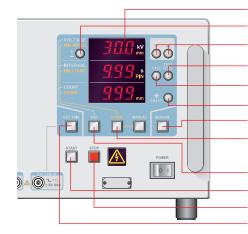
#### Output waveform





#### Front Panel

#### Simple usability



Digital indication: Indicate output voltage, discharge interval, No. of time of discharge

Polarity switching button: Select the discharge polarity

▼▲Up & Down switch : Change the selected value. Up and down quickly with the push continuously

Test level switch: Voltage values preset along conforming to HBM and MM

CALL switch: Enable to preset 5 test patterns

Sweep switch: Enable to sweep from discharge start voltage to the finish voltage with preset voltage unit

MEASURE switch: Switch to BNC terminal for measuring DUT before and after the test

STAGE switch: Select PIN PITCH, PIN COUNT and HOME in the setting items for using semi-automatic

precision type probe stand.

ESD switch: Select VOLTAGE, INTERVAL and COUNT in the setting items

**START switch**: Start test **STOP switch**: Stop test

EXT TRIG switch: Used for starting test with external signal

#### Accessory

Item	Q'ty
Human Body models (HBM) discharge probes (MODEL 01-00054A)	1 set
Machines Model (MM) discharge probes (MODEL 01-00055A)	1 set
(Attached with 2 pcs. of waveform adjustment card MODEL 06-00065A)	
AC code	1 pc.
Instruction manual	1 volume

ESS-6002 / 6008

Free Type Probe Stand 18-00	0075A
Parameter	Specification
Dimension / Mass (probes stand unit)	(W) 200x(H)330x(D)290 mm / Approx. 1.5kg
Dimension / Mass (free board)	(W) 100x(H)27x(D)180 mm (Projection excluded) / Approx. 200g
Vise gap	110 mm
Others	V-shape block included



### **■**Dischargeing figures





When free type probe stand 18-00075A is used

Noise is discharged from the IC clip attached with the probe stand to devices which are fixed using the free board or the V-shape block

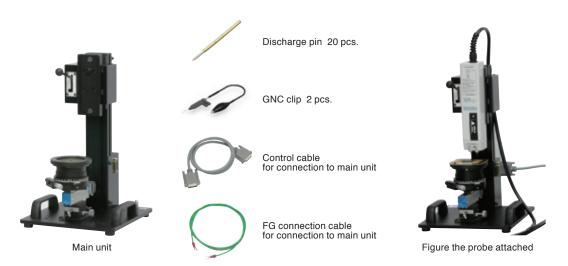


#### Semi-Automatic Precision Type Probe Stand 18-00076A

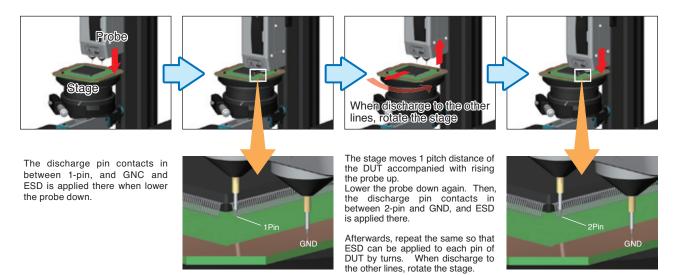
Easy test to semiconductors whose pitches are mm or inch since the minimum resolution accuracy is 0.01mm.

- The stage moves automatically accompanied by the discharge.
- Easy removal and attachment of the probe.
- Available for easy measurement with a measurement equipment after the discharge since the probe can be fixed at the discharge.

Item	Specification	
Dimension / Mass	(W) 250x(H)400x(D) 300 mm / Approx 7 kg	
Applicable IC size	Maximum size: 40 mm X 40mm Minimum lead pitch: 0.4 mm	
X-Y-θ table		
X axis	Manual movement : 20mm with dovetail groove feed screw mechanism	
Y- axis	Motor drive (Maximum velocity: 13 mm/s) Movement: 40 mm (Y resolution: 0.01mm)	
	* Stepping motor & ball screw	
θaxis	Manual movement: 360°	
Z-axis	Manual movement : 20mm (A spring built-in)	
Origin adjustment	Manual	



#### Application example



## **NoiseKen**

Option

#### Waveform Adjustment Card (4 pcs. in 1 set) MODEL: 06-00064A



For changing rise up time or cycle of the waveform (Not specified in Standards)

Human Body models (HBM) probe	Machines models (MM) probe
HBM-F card for HBM (Fast)	MM-HF card for MM (High Frequency)
Rise-up time: 2~4ns (typical)	Cycle: 69~75ns (typical)
HBM-S card for HBM (Slow)	MM-LF card for MM (Low Frequency)
Rise-up time : 6~8ns (typical)	Cycle: 83~89ns (typical)

#### Discharge Clip 2.54mm pitch type MODEL: 08-00013A



Discharge clip 2.54mm pitch type MODEL: 08-00013A Red colord 2 pcs. Black colored 2 pcs.

#### Discharge Clip 0.3mm pitch type MODEL: 08-00014A



Discharge clip 0.3mm pitch type MODEL: 08-00014A Red colored 2 pcs. Black colored 2 pcs.

Option for Free Type Probe Stand : Dust-Protection case MODEL : 11-00012A



Option for Semi-Automatic Precision Type Probe Stand : Dust-Protection case

MODEL: 11-00013A





– M e m o –